


<b>Search Notes</b> 	<b>Application/Control No.</b> 10804087	<b>Applicant(s)/Patent Under Reexamination</b> VALLINEN ET AL.
	<b>Examiner</b> John Shin	<b>Art Unit</b> 3687

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
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INTERFERENCE SEARCH			
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